

**Search Notes**

Application/Control No.

10/633,794

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

HORN ET AL.

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	216, 239, 341.8 458.1- 461.2	8/30/2005	PL
250	353	8/30/2005	PL
356	4.02, 138	8/30/2005	PL
356	141.3	8/30/2005	PL
356	150	8/30/2005	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
250	216	8/30/2005	PL
250	239	8/30/2005	PL
250	353	8/30/2005	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	8/30/2005	PL